

# AM83135-015

# RF & MICROWAVE TRANSISTORS S-BAND RADAR APPLICATIONS

PRELIMINARY DATA

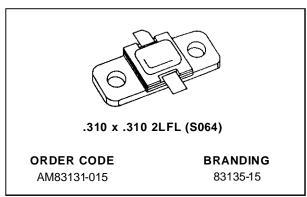
- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTED
- LOW THERMAL RESISTANCE
- INPUT/OUTPUT MATCHING
- OVERLAY GEOMETRY
- METAL/CERAMIC HERMETIC PACKAGE
- P<sub>OUT</sub> = 15 W MIN. WITH 5.2 dB GAIN

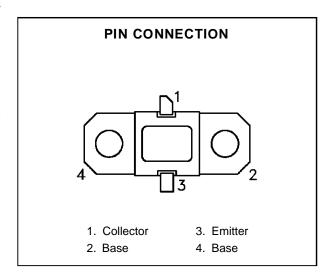
## DESCRIPTION

The AM83135-015 device is a high power silicon bipolar NPN transistor specifically designed for S-Band radar pulsed output and driver applications.

This device is characterized at 100µsec pulse width and 10% duty cycle, but is capable of operation over a range of pulse widths, duty cycles, and temperatures, and can withstand a 3:1 output VSWR with a + 1 dB input overdrive. Low RF thermal resistance, refractory/gold metallization, and computerized automatic wire bonding techniques ensure high reliability and product consistency (including phase characteristics).

The AM83135-015 is supplied in the IMPAC™ Hermetic Metal/Ceramic package with internal Input/Output impedance matching circuitry, and is intended for military and other high reliability applications.





#### **ABSOLUTE MAXIMUM RATINGS** $(T_{case} = 25^{\circ}C)$

Symbol	Parameter	Value	Unit	
Poiss	Power Dissipation* (T <sub>C</sub> ≤ 50°C) 71			
Ic	Device Current*	3.0	А	
Vcc	Collector-Supply Voltage*	46	V	
TJ	Junction Temperature (Pulsed RF Operation)	250	°C	
T <sub>STG</sub>	Storage Temperature	- 65 to +200	°C	

#### THERMAL DATA

R <sub>TH(j-c)</sub>	Junction-Case Thermal Resistance*	2.8	°C/W

<sup>\*</sup>Applies only to rated RF amplifier operation

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# **ELECTRICAL SPECIFICATIONS** (T<sub>case</sub> = 25°C)

## STATIC

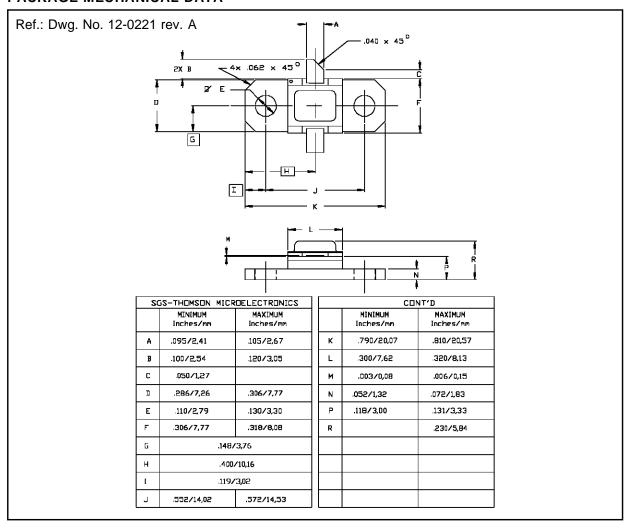
Symbol	Test Conditions	Value			IIn:4		
		Min.	Тур.	Max.	Unit		
BV <sub>CBO</sub>	I <sub>C</sub> = 10 mA	$I_E = 0 \text{ mA}$		55	_		V
BV <sub>EBO</sub>	I <sub>E</sub> = 2 mA	$I_C = 0 \text{ mA}$		3.5	_	_	V
BV <sub>CER</sub>	I <sub>C</sub> = 10 mA	$R_{BE} = 10 \Omega$		55	_	_	V
ICES	V <sub>BE</sub> = 0 V	V <sub>CE</sub> = 40 V		_	_	8	mA
h <sub>FE</sub>	V <sub>CE</sub> = 5 V	I <sub>C</sub> = 1 A		30	_	300	_

## **DYNAMIC**

Symbol	Test Conditions			Value			Unit
Symbol				Min.	Тур.	Max.	Unit
Pout	f = 3.1 – 3.5 GHz	$P_{IN} = 4.5 W$	$V_{CC} = 40 \text{ V}$	15	_	_	W
ης	f = 3.1 – 3.5 GHz	$P_{OUT} = 15 W$	$V_{CC} = 40 \text{ V}$	30	_	_	%
P <sub>G</sub>	f = 3.1 – 3.5 GHz	P <sub>OUT</sub> = 15 W	$V_{CC} = 40 \text{ V}$	5.2			dB

Note: Pulse Width =  $100 \mu$ S Duty Cycle = 10%

#### PACKAGE MECHANICAL DATA



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